Discovery of two new phases of zirconium tetrakis(8-hydroxyquinolinolate): synthesis, crystal structure and their electron transporting characteristics in organic light emitting diodes (OLEDs)†

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Two new phases of zirconium tetrakis(8-hydroxyquinolinolate) (ZrQ₄) have been synthesised and characterised by single crystal X-ray diffraction. Their electrical, electronic, optical and thermal properties have been studied. Their electron transporting characteristics have been investigated in organic light emitting devices where the two phases show remarkable differences in performance. One of the forms (designated α-ZrQ₄) gives significantly lower operating voltage, higher efficiencies and longer lifetime than the other (designated β-ZrQ₄) in organic light emitting devices.

Introduction

Organic light emitting diode (OLED) based displays have become one of the significant flat panel display technologies as evidenced by the production of active matrix OLEDs for mobile phones by Samsung SDI and the introduction of an 11" AM-OLED TV (XEL-1) to the market by Sony. Recent announcement by Samsung of its intention to invest US Dollars 2.2 billion into active matrix OLED televisions (AM-OLED) to bring them into the mainstream TV market has given considerable impetus to the scientists developing materials for the OLED devices.

Long operational lifetime and high electroluminescent efficiencies are very important to commercial success. OLEDs are multilayer devices, typically composed of (i) a hole injector (e.g. copper phthalocyanine (CuPc), 4,4′,4″-tris(N-(2-naphthyl)-N-phenyl-amino)-triphenylamine (2-TNATA), tripyrazinocyclohexane(s), (ii) a hole transporter (e.g. N,N′-bis-(1-naphthalenyl)-N,N′-bis-phenyl-(1,1′-biphenyl)-4,4′-diamine, α-NPB), (iii) an emissive layer (host + dopant), (iv) an electron transporter (e.g. tris(8-hydroxyquinoline)-aluminium (Alq₃)), (v) an electron injector (e.g. LiF, CsF, lithium quinolinolates) and (vi) a cathode (e.g. Al)⁶ to provide charge balance so that efficient devices can be produced. Hole transporters and electron transporters can also be doped with chemical reduction with a sufficiently high reduction potential; (iv) a high ionisation potential (I.P.) to serve as a hole blocker (I.P. > 6 eV); (v) a high glass transition temperature and melting point; (vi) thermal stability up to at least 250 °C (high Tg/Tm/Td); (vii) stability under evaporation conditions for a period of at least 144 hours if vacuum processing is employed; (viii) good stability to moisture and oxygen; (ix) be capable of forming amorphous films so that crystallisation induced degradation is avoided; (x) photostability; (xi) if phosphorescent emitters are used, the triplet energy level of the et should be higher than that of the phosphorescent emitters; (xii) processability to produce uniform and pinhole-free films either by evaporation (small molecules) or by solution casting.

A variety of electron transporters based on metal quinolinolinate(s) (e.g. Alq₃, Inq₃, Gaq₃, Scq₃, Mgq₃), oxadiazole(s), imidazole(s), pyridine derivatives, perfluorinated oligophenylene(s), silole(s), phenanthroline(s), boron compounds and pyrimidone(s) have been reported.⁷–⁹,12,14,17–21 However, Alq₃, despite its low electron mobility and instability to holes, has remained the material of choice due to low cost and acceptable OLED lifetime. However, Alq₃ has three major drawbacks: (i) it leaves behind a considerable amount of residue during sublimation purification...
and OLED production conditions; (ii) the operating voltage is still relatively high and (iii) the perceived toxicity of aluminium compounds.

We have been working on charge transporting materials for OLEDs over the last 10 years and have discovered that zirconium tetrakis(8-hydroxyquinolinolate) (Zr\(_{4}\)) not only acts as a good electron transporter, but also lower the operating voltage and increases the lifetime and efficiency of OLED devices compared to tris(8-hydroxyquinoline)aluminium (Alq\(_3\)).\(^{1,15}\) The stability of Alq\(_3\) is attributed to the fact that at least two isomers (fac and mer) are always present in any Alq\(_3\) sample, thereby preventing crystallisation during device operation. The avoidance of crystallisation is important for long device lifetime.\(^{16}\) It is also important to note that Alq\(_3\) also exists in several forms, denoted by \(\alpha\)-Alq\(_3\), \(\beta\)-Alq\(_3\), \(\gamma\)-Alq\(_3\) and \(\delta\)-Alq\(_3\).\(^{26}\) Zr\(_{4}\) was found to be stable in OLED production equipment at elevated temperature (300 °C) for over 6 weeks under production conditions without undergoing any decomposition, residue or ash formation,\(^{28}\) as established by sampling the material periodically and measuring its properties such as absorption coefficient (extinction coefficient), fluorescence, mass and NMR (proton and \(^{13}\)C) spectroscopy and elemental analysis. This extraordinary stability of Zr\(_{4}\) under production conditions (vacuum thermal evaporation) led us to further investigate its characteristics.

The device performance of Zr\(_{4}\) was found to be remarkably dependent on the preparation conditions and the starting materials. Therefore, we reasoned that there must be at least two phases or isomers of Zr\(_{4}\) existing in the samples, depending on the conditions of synthesis. This paper describes the journey to identify the different phases of Zr\(_{4}\) and their effect on the performance of OLED devices.

It is well known that the preparation method could influence the electrical and electronic properties of a material, so we examined the effect of the nature of starting materials, namely ZrCl\(_4\), Zr(OPr\(_4\)), Zr(O\(_n\)Bu\(_4\)), and zirconium tetrakis(2,2,6,6-tetramethyl-3,5-heptanedionate (Zr(tmhd)\(_4\)), and the solvents namely ethanol, acetonitrile, phenylcyanide, dichloromethane, toluene and tetrahydrofuran. In the course of this work, we discovered that there are at least two forms of Zr\(_{4}\) and only one form (monoclinic, herein after called the \(\alpha\) form, from Zr(OPr\(_4\)) as the starting material) is more electron transporting than Alq\(_3\). The other form (orthorhombic, herein after called the \(\beta\) form, from ZrCl\(_4\) as starting material) is less electron transporting than Alq\(_3\). This paper describes the synthesis and their physical properties, performance in electroluminescent devices and the differences in the conduction mechanisms in selected comparable OLED devices. We have also made comparison with Alq\(_3\), purchased from H.W. Sands (USA) and possibly containing a mixture of different phases of Alq\(_3\), but after purification by double sublimation.

Experimental

Synthesis

The \(\alpha\) form was synthesised by refluxing 8-hydroxyquinoline with zirconium isopropoxide in THF, while the \(\beta\) form was synthesised by reacting 8-hydroxyquinoline with zirconium(IV) tetrakis(2,2,6,6-tetramethyl-3,5-heptanedionate) (Zr(tmhd)\(_4\)) as starting material. Therefore, we reasoned that there must be at least two phases or isomers of Zr\(_{4}\) existing in the samples, depending on the conditions of synthesis. This paper describes the journey to identify the different phases of Zr\(_{4}\) and their effect on the performance of OLED devices. In the course of this work, we discovered that there are at least two forms of Zr\(_{4}\) and only one form (monoclinic, herein after called the \(\alpha\) form, from Zr(OPr\(_4\)) as the starting material) is more electron transporting than Alq\(_3\). The other form (orthorhombic, herein after called the \(\beta\) form, from ZrCl\(_4\) as starting material) is less electron transporting than Alq\(_3\). This paper describes the synthesis and their physical properties, performance in electroluminescent devices and the differences in the conduction mechanisms in selected comparable OLED devices. We have also made comparison with Alq\(_3\), purchased from H.W. Sands (USA) and possibly containing a mixture of different phases of Alq\(_3\), but after purification by double sublimation.

![Scheme 1](image1)

**Scheme 1** Synthesis of \(\alpha\)-Zr\(_{4}\).

![Scheme 2](image2)

**Scheme 2** Synthesis of \(\beta\)-Zr\(_{4}\).

<table>
<thead>
<tr>
<th>Zr(_{4})</th>
<th>Alq(_3)</th>
</tr>
</thead>
<tbody>
<tr>
<td>(\alpha)</td>
<td>(\beta)</td>
</tr>
<tr>
<td>Monoclinic, (P2_1/c)</td>
<td>Orthorhombic, (Pca2_1)</td>
</tr>
<tr>
<td>300</td>
<td>20.1120(7), 8.2920(3), 17.3925(6)</td>
</tr>
<tr>
<td>90, 90, 90</td>
<td>90, 90, 90</td>
</tr>
<tr>
<td>2822.7 (3)</td>
<td>2900.52 (18)</td>
</tr>
<tr>
<td>0.44</td>
<td>0.43</td>
</tr>
<tr>
<td>0.36 × 0.29 × 0.25</td>
<td>0.36 × 0.30 × 0.13</td>
</tr>
</tbody>
</table>

| Crystal data | Crystal system, space group | Temperature/K | \(a\), \(b\), \(c\)/Å | \(a\), \(\beta\), \(\gamma\)/° | \(V/Å^3\) | \(\mu\)/mm\(^{-1}\) | Crystal size/mm | No. of measured, independent and observed \([I > 2\sigma(I)]\) reflections | \(R_{int}\) | \(R[F^2 > 2\sigma(F)]\), \(wR(F)^2\), \(S\) | No. of reflections | No. of parameters | No. of restraints | \(\Delta P_{max}/\Delta P_{max}/e\) A\(^{-1}\) | Flack parameter |
| --- | --- | --- | --- | --- | --- | --- | --- | --- | --- | --- | --- | --- | --- | --- | --- | --- |
| Zr\(_{4}\) | Alq\(_3\) |
| --- | --- | --- | --- | --- | --- | --- | --- | --- | --- | --- | --- | --- | --- | --- | --- | --- |
| Monoclinic, \(P2_1/c\) | Orthorhombic, \(Pca2_1\) | 300 | 11.2179(7), 14.6724(10), 17.2101(12) | 90, 94.816 (2), 90 | 2822.7 (3) | 0.44 | 0.36 × 0.29 × 0.25 | 17566, 6421, 4523 | 0.058 | 0.037, 0.086, 0.95 | 6421 | 406 | 0 | 0.62, –0.56 | — |
| Orthorhombic, \(Pca2_1\) | Monoclinic, \(P2_1/c\) | 20.1120(7), 8.2920(3), 17.3925(6) | 90, 90, 90 | 2900.52 (18) | 0.43 | 0.36 × 0.30 × 0.13 | 17182, 6522, 5811 | 0.040 | 0.025, 0.062, 0.99 | 6522 | 407 | 1 | 0.54, –0.24 | 0.13(2) |
chloride (Scheme 1 and 2). Zrq4 was purified by quadruple sublimation at 280 °C under vacuum (pressure of 1 × 10⁻⁶ Torr).

**Device fabrication**

Electron-only devices were fabricated by evaporating the Zrq4 to produce a layer thickness of 400 nm onto Mg/Al coated ITO/glass and sandwiching it with a bottom contact of another layer of Mg/Al (200 nm). Alq3 devices were also made for comparison.

Electroluminescent devices were fabricated by thermal evaporation method using a multi-chamber OLED pilot plant machine (Solciet, manufactured by ULVAC, Japan). The devices were fabricated on a patterned pixelated ITO substrate (40 ohms per square surface resistance, Hitachi High Tech., Japan), cleaned with water, acetone, isopropyl alcohol and water (in that order), then dried at 150 °C for 20 minutes and then subjected to ozone cleaning (UV irradiation, 185 nm) at 150 °C for 10 minutes. The substrate was then plasma cleaned in the presence of oxygen for 25 seconds and moved into the vacuum chamber from which the hole injector [5,10,15,20-tetra(p-tolyl)-21H,23H-porphine zinc(II) (ZnTPTP), 50 nm], hole transporter [N,N'-bis-(1-naphthalenyl)-N, N'-bis-phenyl-(1,1'-biphenyl)-4,4'-diamine, (α-NPB), 50 nm], host : dopant [Alq3 (50 nm) : (0.1 nm) N,N'-diphenylquinacridone (DPQA), co-evaporation], and electron transporter [either Alq3 or Zrq4 (20 nm)] were sequentially deposited. The evaporation rates of ZnTPTP, α-NPB, (Alq3, DPQA), Zrq4 and LiF (electron injector) were 1 As⁻¹, 1.5 As⁻¹, (1 As⁻¹, 0.1 As⁻¹), 1 A s⁻¹, 0.05 A s⁻¹, respectively.

Directly from the vacuum chamber all the devices were encapsulated with a UV curable adhesive (Nagase) with glass backplates in a glovebox filled with dry nitrogen so that the device is not exposed to air. The electrical and optical measurements were carried out by a computer-controlled Keithley 2400 Source Meter and a Minolta (CS-1000) spectrometer, respectively. HOMO–LUMO levels were determined by cyclic voltammetry (by computer controlled potentiostat PAR 273 or CHI 600D) and from band gap measurements by absorption spectroscopy of thin films produced by vacuum thermal evaporation. Capacitance measurements were made on thin films as well as compacted discs using an Impedance Analyser (Hewlett Packard, 4284A).

**Crystal structure analysis**

Single crystals of both α-Zrq4 and β-Zrq4 were grown by slow vacuum sublimation at a temperature of 275 °C and a pressure of 5 × 10⁻⁶ Torr.

X-Ray crystallographic studies were carried out on single crystals of α-Zrq4 and β-Zrq4: data collections were performed at 150 and 300 K, respectively, as ω scans on a Bruker SMART1000 CCD area detector diffractometer, using graphite-monochromated Mo-Kα radiation (λ = 0.71073 Å). Data were corrected for Lorentz and polarization effects. The structures were solved by direct methods using SHELXS97, developed by iterative cycles of least-squares refinement and difference Fourier synthesis, and refined by full-matrix least-squares on F² using SHELXL97. Crystallographic Information Files were prepared using enCIFer and validated using PLATON. All non-hydrogen atoms were

<table>
<thead>
<tr>
<th>Material</th>
<th>Reagent</th>
<th>Solvent</th>
<th>Base</th>
<th>Synthesis yield (%)</th>
<th>Soxhlet extraction yield (%)</th>
<th>Sublimation yield (%)</th>
<th>Overall yield (%)</th>
</tr>
</thead>
<tbody>
<tr>
<td>α-Zrq4</td>
<td>Zr(OPr)₄</td>
<td>THF</td>
<td>None</td>
<td>88</td>
<td>Not needed</td>
<td>91</td>
<td>80</td>
</tr>
<tr>
<td>β-Zrq4</td>
<td>ZrCl₄</td>
<td>Ethanol</td>
<td>Piperidine</td>
<td>93</td>
<td>77</td>
<td>92</td>
<td>66</td>
</tr>
</tbody>
</table>

**Table 2** Summary of synthesis conditions and yields for zirconium complexes

![Fig. 1 Crystal conformations for α-Zrq4 and β-Zrq4.](image)
refined anisotropically. Hydrogen atoms were introduced at geometrically calculated positions and refined using a riding model with \(U_{	ext{iso}}(H) = 1.2U_{	ext{eq}}(C)\). Crystal data and structure refinement details are summarised in Table 1.

**Results and discussion**

The synthesis of Zrq\(_4\) has been reported by Frazer and Rimmer,\(^{22}\) who also prepared Hfq\(_4\), by reacting ZrCl\(_4\) with 8-quinolinol in THF, first producing Zrq\(_4\), 2hq (hq = 8-hydroxyquinoline) and then Zrq\(_4\) upon sublimation purification. An X-ray crystal structure determination of Zrq\(_4\), 3toluene has been reported by Lewis and Fay.\(^{23}\)

Table 3  Selected geometric parameters (\(\text{\AA}, ^\circ\))

<table>
<thead>
<tr>
<th>(\alpha)-Zrq(_4)</th>
<th>(\beta)-Zrq(_4)</th>
</tr>
</thead>
<tbody>
<tr>
<td>Zr1–O1</td>
<td>2.110(2)</td>
</tr>
<tr>
<td>Zr1–O2</td>
<td>2.097(2)</td>
</tr>
<tr>
<td>Zr1–O3</td>
<td>2.096(2)</td>
</tr>
<tr>
<td>Zr1–O4</td>
<td>2.120(2)</td>
</tr>
<tr>
<td>O1–Zr1–O2</td>
<td>81.59(6)</td>
</tr>
<tr>
<td>O1–Zr1–O3</td>
<td>143.85(6)</td>
</tr>
<tr>
<td>O1–Zr1–O4</td>
<td>75.98(2)</td>
</tr>
<tr>
<td>Zr1–O1</td>
<td>2.1152(14)</td>
</tr>
<tr>
<td>Zr1–O2</td>
<td>2.109(2)</td>
</tr>
<tr>
<td>Zr1–O3</td>
<td>2.113(2)</td>
</tr>
<tr>
<td>Zr1–O4</td>
<td>2.1152(14)</td>
</tr>
<tr>
<td>O1–Zr1–O2</td>
<td>81.59(6)</td>
</tr>
<tr>
<td>O1–Zr1–O3</td>
<td>143.85(6)</td>
</tr>
<tr>
<td>O1–Zr1–O4</td>
<td>75.98(2)</td>
</tr>
</tbody>
</table>

We prepared Zrq\(_4\) from a range of solvents including ethanol, acetonitrile, phenyl cyanide, dichloromethane, toluene and THF by reacting ZrCl\(_4\) with hq. We found that ethanol gave the best yield of 93%. The product from this method required Soxhlet extraction using dioxane to remove any traces of chlorine before sublimation, but the yield after soxhlet extraction was only 77%. We refer to this product as \(\beta\)-Zrq\(_4\). For the fabrication of OLEDs, high purity materials (purity better than 99.95%) are required which are free of chlorine (and certain trace metals such as Cr, Fe, Co, Ni). Thus, alternative synthetic methods were investigated and we found that the synthesis based on the starting material zirconium isopropoxide gave a high yield (88%) of a very pure product which did not require Soxhlet extraction. The yield for the sublimation step was 91%. We assigned the designation \(\alpha\)-Zrq\(_4\) to this product (Table 2).

Crystal structures of \(\alpha\)-Zrq\(_4\) and \(\beta\)-Zrq\(_4\)

In both \(\alpha\)-Zrq\(_4\) and \(\beta\)-Zrq\(_4\) the metal centre is eight-coordinated by four chelating N,O pairs from four 8-hydroxyquinolinolate ligands (Fig. 1). The coordination by each pair is strongly asymmetric, with Zr–O distances of around 2.1 \(\text{\AA}\) and Zr–N distances of over 2.4 \(\text{\AA}\) (Table 3). The dihedral angles between the five-membered ZrNCCO chelate rings show similar but not identical patterns (please see Table S1 in the ESI†), indicative of broadly similar overall geometry. As neither space group is symmorphic, both contain equal amounts of each enantiomer, and by selecting corresponding enantiomers from each phase it is possible to illustrate the fact that the molecular structures are indeed very similar (Fig. 1).

The extended structures of both forms feature extensive C–C–H–O–C interactions, but only the \(\alpha\) form exhibits short C–H–H–O contacts and short centroid–centroid distances between \(\pi\) systems (Table S1 in the ESI†). The higher density of the \(\alpha\) form (1.571 g cm\(^{-3}\)) compared to that of the \(\beta\)-form (1.529 g cm\(^{-3}\)) suggests that the former has more efficient packing (Fig. 2) and is therefore expected to be the more stable form. This was indeed confirmed by in situ q-mass spectroscopy where the \(\alpha\) form was found to survive longer (no decomposition) than the \(\beta\)-Zrq\(_4\) on extended heating under OLED production conditions.\(^{29,30}\)

Differential scanning calorimetry (Fig. 3) of \(\alpha\)-Zrq\(_4\) shows a pre-peak (i.e., a peak before the main melting point) whereas the \(\beta\)-Zrq\(_4\) form does not, providing a further distinction between the two forms. Such pre-peaks are usually observed for a variety of materials including metal complexes and polymers where there are both crystalline and amorphous components present or there are slight changes in the conformation of the molecules (twisting).\(^{38}\) We believe that the pre-peak here is due to the amorphous component of \(\alpha\)-Zrq\(_4\) crystallising on annealing (heating). Fig. 4 shows the absorption spectra as well as fluorescence spectra of vacuum evaporated thin films of \(\alpha\)-Zrq\(_4\) and \(\beta\)-Zrq\(_4\). There are no differences in absorption maximum, but the absorption edge (band gap) is slightly different, 2.68 ± 0.01 eV for the \(\alpha\) form and 2.73 ± 0.01 eV for the \(\beta\) form (Table 4). The fluorescence maximum of thin films of \(\alpha\)-Zrq\(_4\) occurs at slightly longer wavelength (523 ± 1 nm) than that for \(\beta\)-Zrq\(_4\) (518 ± 1 nm); this is expected as the former has lower optical band gap in addition to losses due to energy transfer to the vibrational energy.
levels (the band gap is not discrete in molecular solids). The fluorescence band gap is correspondingly lower for α-Zrq4 (2.37 eV) than for β-Zrq4 (2.39 eV). However, the excited state of β-Zrq4 is more stabilised (0.37 eV below the LUMO level) as opposed to that of α-Zrq4 (0.31 eV). The difference in the FWHM of the fluorescence spectra of the two forms indicates that the excited states of the two forms are different as expected.

The absorption and emission spectra of toluene solutions of the α-Zrq4 and β-Zrq4 forms were identical.

Cyclic voltammetry (CV) was performed in acetonitrile solvent containing the analyte (α-Zrq4 or β-Zrq4, 0.5 mM) and supporting electrolyte (tetrabutyl ammonium tetrafluoroborate (10 mM). The working, reference and secondary electrodes were Pt foil (2 cm²), Ag/AgCl and Pt wire, respectively.

The CV’s were performed in both oxidation (0 to +2.0 V) and reduction (0 to −1.9 V) regions at various scan rates. Repetitive cyclic voltammograms were also performed in both the regions. The cyclic voltammetry in the oxidative region (0 to +2.0 V) was found to be irreversible whereas in the reductive region (0 to −1.9 V), it was quasi-reversible. The anodic peak current in the oxidative region was found to decrease with repetitive cycling owing to deposition of an insulating layer (brown coloration was also discernible at the electrode). However, the cathodic and anodic peaks in the reduction region were very reproducible (Fig. 5–7), the main cathodic peak being diffusion controlled (i_p proportional to r^½) and the small peak seen around −1.6 V vs. Ag/AgCl for α-Zrq4 was confirmed to be an adsorption pre-wave (i_p proportional to r) and not a redox peak. It is interesting to note that only the α form shows the adsorption pre-wave whereas the β form does not. We then used the reduction region to work out the LUMO level of the compounds under study in this paper. The LUMO levels were determined from the equation in ref. 33:

\[
\text{HOMO or LUMO} = -(E_{1/2} \text{ vs. NHE} + 4.40) \text{ eV}
\]

(NHE: Normal Hydrogen Electrode).
Table 4  Thermal and optical properties of α-Zrq₄ and β-Zrq₄

<table>
<thead>
<tr>
<th>Parameter</th>
<th>α-Zrq₄</th>
<th>β-Zrq₄</th>
</tr>
</thead>
<tbody>
<tr>
<td>Melting point (DSC)</td>
<td>393 °C and pre-peak at 355 °C</td>
<td>393 °C</td>
</tr>
<tr>
<td>Thermal stability, weight loss (5%)</td>
<td>375 °C</td>
<td>375 °C</td>
</tr>
<tr>
<td>Decomposition kinetics at 380 °C under nitrogen. Initial rate, first order</td>
<td>4.67 × 10⁻⁴ s⁻¹</td>
<td>3.60 × 10⁻⁴ s⁻¹</td>
</tr>
<tr>
<td>Solubility in acetonitrile/g l⁻¹</td>
<td>0.040</td>
<td>0.064</td>
</tr>
<tr>
<td>Absorption spectroscopy in toluene, λ_max/nm (ε_max/mol⁻¹ cm⁻¹)</td>
<td>387 ([1.30 ± 0.07] × 10⁵)</td>
<td>387 ([1.25 ± 0.07] × 10⁵)</td>
</tr>
<tr>
<td>Absorption spectroscopy (evaporated thin films), λ_max/nm</td>
<td>395 ± 1</td>
<td>395 ± 2</td>
</tr>
<tr>
<td>Fluorescence spectroscopy in toluene, λ_max/nm, [FWHM] (excitation at 400 nm)</td>
<td>517 ± 1 [76.3 nm]</td>
<td>517 ± 1 [76.3 nm]</td>
</tr>
<tr>
<td>Fluorescence spectroscopy, evaporated thin films, λ_max/nm, [FWHM] (excitation at 400 nm)</td>
<td>523 ± 1 [72 ± 1]</td>
<td>518 ± 1 [79 ± 1]</td>
</tr>
<tr>
<td>Band gap from absorption edge (E_g/eV)</td>
<td>2.68 ± 0.01</td>
<td>2.73 ± 0.01</td>
</tr>
<tr>
<td>Fluorescence band gap/eV</td>
<td>2.37 ± 0.01</td>
<td>2.39 ± 0.01</td>
</tr>
<tr>
<td>Temperature to give an evaporation rate of 1 Å s⁻¹ at a pressure of 7.5 × 10⁻⁷ Torr</td>
<td>298 °C</td>
<td>305 °C</td>
</tr>
</tbody>
</table>

Fig. 5  Cyclic voltammetry; analyte 0.5 mM, supporting electrolyte (tetrabutyl ammonium tetrafluoroborate, 10 mM), solvent: acetonitrile, scan rate: 10 mV S⁻¹, working electrode: Pt foil. Reference electrode: Ag/AgCl.

Fig. 6  Cyclic voltammetry: α-Zrq₄, different scan rates, analyte 0.5 mM, supporting electrolyte (tetrabutyl ammonium tetrafluoroborate, 10 mM), solvent: acetonitrile, working electrode: Pt foil. Reference electrode: Ag/AgCl.

Fig. 7  Cyclic voltammetry: β-Zrq₄; different scan rates, analyte 0.5 mM, supporting electrolyte (tetrabutyl ammonium tetrafluoroborate, 10 mM), solvent: acetonitrile, working electrode: Pt foil. Reference electrode: Ag/AgCl.

Fig. 8  Electron only device, HOMO–LUMO values of α-Zrq₄, β-Zrq₄, Alq₃, Mg : Al alloy was used as the low work function electrode.

Table 5  HOMO–LUMO levels of the two forms of Zrq₄

<table>
<thead>
<tr>
<th>Material</th>
<th>LUMO/eV</th>
<th>HOMO/eV</th>
</tr>
</thead>
<tbody>
<tr>
<td>α-Zrq₄ (from cyclic voltammetry)</td>
<td>−2.94 ± 0.02</td>
<td>−5.62 ± 0.02</td>
</tr>
<tr>
<td>α-Zrq₄ (photoelectron spectroscopy), measured by Dr T. Yuki, Pioneer, Japan</td>
<td>−2.90</td>
<td>−5.60</td>
</tr>
<tr>
<td>β-Zrq₄ (from cyclic voltammetry)</td>
<td>−2.94 ± 0.02</td>
<td>−5.70 ± 0.02</td>
</tr>
<tr>
<td>Alq₃ (from cyclic voltammetry)</td>
<td>−2.90 ± 0.02</td>
<td>−5.70 ± 0.02</td>
</tr>
</tbody>
</table>

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The $E_{1/2}$ employed here were determined from the derivative of the cyclic voltammograms.

The cathodic peaks and its derivative of $\alpha$-Zrq4 were identical to those of $\beta$-Zrq4. Using the optical band gap from the absorption edge, the corresponding HOMO levels were then determined. The values are given in Table 5.

The electrical conductivity of the powders was measured as compacted discs using a two probe method. The electrical conductivities of compacted discs of $\alpha$-Zrq4, $\beta$-Zrq4 and Alq3 were found to be $5.8 \times 10^{-13}$, $3.0 \times 10^{-13}$ and $5.0 \times 10^{-13}$ S cm$^{-1}$, respectively.

Electron only devices (Fig. 8) show that the electron injection and transport in these data for diode, tunnelling (Fowler Nordheim) and SCLC vs. current density described by vacuum thermal evaporation, exhibited non-linear behaviour as shown in Fig. 9. We fitted these data for diode, tunnelling (Fowler Nordheim) and SCLC models. The data fitted the SCLC model but not the others.

Electron only devices (Fig. 8) show that the electron injection (Fig. 9) follows the order $\alpha$-Zrq4 > Alq3 > $\beta$-Zrq4. The current density ($J_a$) vs. voltage ($V$) plots were found to satisfy the SCLC model. From the ohmic region ($J_a$ proportional to $V$) and the space charge region ($J_a$ proportional to $V^2$), conductivity and mobility values were determined. The conductivity of thin films of $\alpha$-Zrq4, $\beta$-Zrq4 and Alq3 were found to be $5.3 \times 10^{-10}$, $1.3 \times 10^{-13}$ and $1.9 \times 10^{-11}$ S cm$^{-1}$, respectively, and the mobility values were estimated to be $1.7 \times 10^{-7}$, $1.6 \times 10^{-8}$ and $1.3 \times 10^{-7}$ cm$^2$ V$^{-1}$ s$^{-1}$, respectively, using the equation:

$$J_{SCLC} = (9/8)e\mu V^2/d^3$$

where $J_{SCLC}$ = current density in the SCLC region, $e$ = permittivity, $\mu$ = mobility, $V$ = voltage and $d$ = thickness.

The conductivity, mobility, charge carrier density and the permittivity of the two forms of Zrq4 are compared with Alq3 in Table 6. The permittivity of Alq3 was found to be 3.06 $\pm$ 0.1 which is comparable to the value of 3.15 reported in ref. 30.

The mobility value measured in this work for Alq3 is comparable to the previously published value of $5 \times 10^{-7}$ cm$^2$ V$^{-1}$ s$^{-1}$. These data are summarised in Table 6. There is a substantial difference in conductivities between the compacted discs of the powders and the amorphous films produced by vacuum thermal evaporation which is possibly due to the morphology and the nature of packing.

$\alpha$-Zrq4 has nearly ten fold higher mobility and $4 \times 10^3$ fold higher conductivity than $\beta$-Zrq4. We wanted to establish how

<table>
<thead>
<tr>
<th>Parameter</th>
<th>$\alpha$-Zrq4</th>
<th>$\beta$-Zrq4</th>
<th>Alq3</th>
</tr>
</thead>
<tbody>
<tr>
<td>Conductivity/S cm$^{-1}$ (compacted disc, 2-probe measurements)</td>
<td>$5.8 \times 10^{-13}$ [0.690 mm]</td>
<td>$3.0 \times 10^{-13}$ [0.477 mm]</td>
<td>$5.0 \times 10^{-13}$ [1.36 mm]</td>
</tr>
<tr>
<td>Conductivity/S cm$^{-1}$ (thin films, electron only devices) [film thickness]</td>
<td>$5.3 \times 10^{-10}$ [420 nm]</td>
<td>$1.3 \times 10^{-13}$ [420 nm]</td>
<td>$1.9 \times 10^{-13}$ [300 nm]</td>
</tr>
<tr>
<td>Mobility/cm$^2$ V$^{-1}$ s$^{-1}$ from the space charge limited region of electron only devices, Mg/Al contacts</td>
<td>$1.7 \times 10^{-7}$</td>
<td>$1.6 \times 10^{-8}$</td>
<td>$1.3 \times 10^{-7}$</td>
</tr>
<tr>
<td>Charge carrier density/cm$^{-3}$</td>
<td>$2.0 \times 10^7$</td>
<td>$4.8 \times 10^7$</td>
<td>$8.7 \times 10^6$</td>
</tr>
<tr>
<td>Relative permittivity ($\varepsilon_r$) (frequency range: 100 Hz–1 MHz)</td>
<td>$3.6 \pm 0.1$</td>
<td>$3.02 \pm 0.1$</td>
<td>$3.06 \pm 0.1$</td>
</tr>
</tbody>
</table>

Fig. 9 Electron only devices, current density (mA cm$^{-2}$) vs. field (V cm$^{-1}$). (a) ITO/Mg : Al alloy/$\alpha$-Zrq4 (420 nm)/Mg : Al alloy; (b) ITO/Mg : Al/$\beta$-Zrq4 (420 nm)/Mg : Al; (c) ITO/Mg: Al/Alq3 (300 nm)/Mg : Al.

Fig. 10 HOMO–LUMO energy levels for ZnTpTp (hole injector), $\alpha$-NPB (holes transporter), Alq3 (Host), DPQA (green dopant), Zrq4 (electron transporter).
much influence this would have on the performance of light emitting devices (OLEDs).

**Device performance**

We fabricated green OLEDs having the structure: glass/ITO/ZnTPTP (50 nm)/α-NPB (50 nm)/Alq3:DPQA (50 : 0.1 nm)/ETL (20 nm)/LiF(0.5 nm)/Al, where ETL is α-ZrQ4, β-ZrQ4 or Alq3 using the Solciet OLED Pilot Plant equipment. The energy level diagram for this device structure under zero bias is depicted in Fig. 10.

The current density ($J_d$) vs. voltage ($V$), luminance (cd m$^{-2}$) vs. voltage ($V$), current efficiency (cd A$^{-1}$) vs. luminance and power efficiency (lm W$^{-1}$) vs. luminance are shown in Fig. 11–14. The current density vs. voltage plot very clearly shows that the current injection and transport from the α-ZrQ4 is the highest followed by Alq3 and then β-ZrQ4 (i.e., α-ZrQ4 > Alq3 > β-ZrQ4), simply following the order of the electron mobility and film conductivity, consistent with our findings on the electron only devices.

Similarly, luminance vs. voltage plot shows that the operating voltage for any given luminance is also lowest for the α-form (i.e., the order is α-ZrQ4 < Alq3 < β-ZrQ4), simply following the order of the electron mobility and film conductivity, consistent with our findings on the electron only devices. The current efficiency at 1000 cd m$^{-2}$ for α-ZrQ4 devices is 11 cd A$^{-1}$ as opposed to 6.5 cd A$^{-1}$ for the β-ZrQ4 based devices (Table 7). The power efficiency of the devices from the α-form (3 lm W$^{-1}$) is three times as high as that from the β-form (1 lm W$^{-1}$) at 1000 cd m$^{-2}$. The turn-on voltage of α-ZrQ4 (2.5 V) is half that for identical devices with Alq3 (5.0 V), while that of β-ZrQ4 (7.0 V) is 2 V higher than that of Alq3 based devices. We attribute this to the high conductivity, mobility and charge carrier density of α-ZrQ4 compared to the β-ZrQ4.

This difference is significant and indicates the remarkable influence of the different phases and the importance in selecting the appropriate form (phase) of the complex to achieve good results.

The device characteristics are summarised in Table 7.
Parameter | ETL–Alq₃ | ETL–α-Zrq₄ | ETL–β-Zrq₄
--- | --- | --- | ---
Turn-on voltage (V₁/₂) measured at 1 cd m⁻² | 5.0 | 2.5 | 7.0
V at 20 mA cm⁻² | 14.0 | 11.0 | 24.0
V at 1000 cd m⁻² | 12.5 | 10.0 | 24.0
Current efficiency (cd A⁻¹) at 1000 cd m⁻² | 9.5 | 11.0 | 6.5
Power efficiency at 1000 cd m⁻² | 2.0 | 3.0 | 1.0
Colour co-ordinates (x and y) | (0.33, 0.64) | (0.30, 0.67) | (0.31, 0.65)
Lifetime at 1200 cd m⁻² (for 30% reduction) | 1500 | 5000 | Not monitored because of its high operating voltage
Half-life at 1200 cd m⁻² (for 50% reduction), (t₀/2h), extrapolated | 8000 | 50 000 | Not monitored because of its high operating voltage

Table 8 Summary of voltage ranges for Ohmic and SCL regions

| Device | Ohmic region (Jₐ ∝ V) | SCLC region (Jₐ ∝ V⁰) | Maximum m value (Jₐ ∝ Vᵐ⁺¹)
--- | --- | --- | ---
α-Zrq₄ | 0 < V < 1 V | 1 < V < 7 V | 5.4
Alq₃ | 0 < V < 1 V | 1 < V < 3 V | 4.9
β-Zrq₄ | 0 < V < 2 V | 2 < V < 10 | 11.8

Mechanism of carrier injection

The current density vs. voltage plots for α-Zrq₄, β-Zrq₄ and Alq₃ devices are shown in Fig. 11. Jₐ vs. V were fitted to normal diode, tunnelling (Fowler Nordheim) and SCLC models and we found that all the data fitted the SCLC model. None of the data fitted diode or tunnelling models. At very low voltages, the current varies linearly with voltage (ohmic relationship) and at intermediate voltages, the current becomes proportional to V⁰ (Child’s Law, Table 8). At high fields, the current increases proportionately with Vᵐ according to the equation:

\[ Jₐ = A V^{m+1} / d^{2m+3} \]

where A is a constant.

The fact that the current continues to increase with Vᵐ indicates that there is a distribution of traps within the band gap of the material. The substantial differences in the m values between the α and the β form indicate that the distribution of traps within the layers is different, as expected from the different crystallographic forms which would be present even in amorphous films.

The lifetime measurements (Fig. 15) were carried out on α-Zrq₄ and Alq₃ devices at an initial luminance of 1200 cd m⁻² under constant current driving. The luminance vs. time plots show that α-Zrq₄ has a longer lifetime than Alq₃. Because the devices based on the β-Zrq₄ required too high a voltage, the lifetime measurements on these devices were not performed. The lifetime (t₀/2) for the luminance from 1200 cd m⁻² to 840 cd m⁻² is 1500 hours for Alq₃ based devices as opposed to 5000 hours for α-Zrq₄ and the extrapolated half-life values are 8000 hours and 50 000 hours, respectively. This remarkable enhancement in lifetime is attributed to the stability of α-Zrq₄, in particular to holes. The luminescence decay of α-Zrq₄ devices takes place in two stages unlike Alq₃ based devices. This is currently under investigation.

Drift voltage versus time \[ V(t) = \left( V_{i} - V₀ \right) / t₀ \] plots show that α-Zrq₄ has lower drift voltage than Alq₃ based devices, indicating that Zrq₄ is not prone to degradation to holes, in contrast to Alq₃. Low drift voltage is very important for stable operation of displays as otherwise an expensive compensation mechanism has to be built into the electronic drivers of the displays.

In this paper, we have compared the performance of fluorescent green OLED devices with α-Zrq₄ and Alq₃ as electron transporters where the former shows superior behaviour: however, the same has been found to be true for red (both fluorescent and phosphorescent), green (phosphorescent) and blue (both fluorescent and phosphorescent) emitting OLEDs. These results will be published elsewhere.

Conclusions

Differences in the characteristics of the devices constructed from α-Zrq₄ and β-Zrq₄, prepared from zirconium isoproxipoxide and zirconium chloride, respectively, have been explained on the basis of their differences in crystal structure (and therefore morphology), mobility and conductivity. Surprisingly, the difference in the HOMO–LUMO levels of the two forms is very small. This paper illustrates the importance of establishing the possibility of existence of different phases of metal complexes before discounting them as unsuitable for device applications.
particularly in OLEDs. Surprisingly, one form does not convert into another under normal sublimation conditions.

The two forms show substantial differences in electrical and electronic properties. The α-form was found to be superior to Alq3 in electron transport and lifetime while the β-form was inferior to Alq3, clearly indicating the need for further studies of other metal complexes used as electron transporters as to the existence of different forms (phases). Our results raise the obvious question of whether there are any more phases of Zrq4. Further studies of Zrq4 as electron transporters with other blue to orange emission organic materials might help to give a definite answer to this question. In OLEDs, it would be interesting to investigate the possibility of different phases of Hfq4.

The superior quality of α-Zrq4 has led a number of display manufacturers to choose this material over Alq3 as an electron transporter.

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References